

Search Notes

Application/Control No.

10/713,210

Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
Previous search updated		8/11/05	JN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR